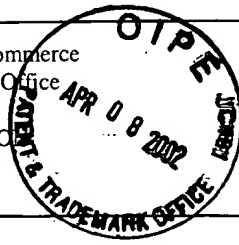


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Attorney Docket No.: 0941.63365

Serial No.: 09/425,788

Applicant: Abarra et al.

Filing Date: October 22, 1999

Group: 1773

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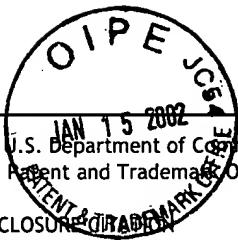
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H. Wilson 5/27/02